

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/802,649	KITAGAWA, HITOSHI	
		Examiner	Art Unit	
		Kianni C. Kaveh	2883	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,882,782	04-2005	Conzone et al.	385/49
	B	US-2003/0174955	09-2003	Chen et al.	385/42
	C	US-6,836,598	12-2004	Chen et al.	385/42
	D	US-2003/0039461	02-2003	How Kee Chun et al.	385/140
	E	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	('Integrated-optical wavelength sensor with self-compensation of thermally induced phase shifts by use of a LiNbO ₃ unbalanced Mach-Zehnder interferometer'; 10/10/2002/vol. 41, no. 29/Applied Optics; pages 6211-6219)
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.